

Issue Classification



Application/Control No.
10757115
Examiner
Nguyen, Hiep

Applicant(s)/Patent Under Reexamination
SMITH ET AL.
Art Unit
2816

ORIGINAL

INTERNATIONAL CLASSIFICATION

CLASS	SUBCLASS	CLAIMED			NON-CLAIMED							
		H	0	3	K							
327	108							3 / 00				
CROSS REFERENCE(S)												
SUBCLASS (ONE SUBCLASS PER BLOCK)												
327	109	110	111	112					538			
326	82	83	84	85					86			

Hiep Nguyen 06-14-07
(Assistant Examiner) (Date)

Tuant Lam

[Signature]
(Legal Instruments Examiner) (Date)
6/14/07

TUANT LAM
PRIMARY EXAMINER
(Primary Examiner) (Date)
6/14/07

Total Claims Allowed:
20

O.G. Print Claim(s) 1
O.G. Print Figure 1